

## CERTIFICATE OF COMPLIANCE

According to EMC 2004/108/EC

**Applicant Name** : Zhangzhou Lilliput Electronics Co., Ltd.  
**Applicant Address** : The Mansion of Optoelectronic Hengsan Road, Lantian Industrial Zone, Zhangzhou, Fujian, China  
**Manufacturer by** : Zhangzhou Lilliput Electronics Co., Ltd.  
**Manufacturer's Address** : The Mansion of Optoelectronic Hengsan Road, Lantian Industrial Zone, Zhangzhou, Fujian, China  
**Product Description** : TFT LCD Color Monitor  
**Model / Part Numbers** : FA801-NP/C/T, QT-802P/B-AVG/AV-TP  
**Trade Marks** : LILLIPUT / Quixun  
**Serial Number Tested** : Prototype  
**Date of Testing** : 2008, June 6<sup>th</sup>  
**Test Report Number** : ZHA-0805-6968-CE

*This is to certify that the product identified above is in compliance with the essential requirements of the following standards:*

**Emission per EN 55013: 2001+ A1: 2003 + A2: 2006 & EN 55022: 2006, Class B**

**EN 55013: 2001+ A1: 2003 + A2: 2006:**

- For Disturbance voltage at the mains terminals.
- For Disturbance voltage at the antenna terminals.
- For Disturbance power.
- For Radiated disturbances

**EN 55022: 2006 Conducted and Radiated Emissions**

**EN 61000-3-2: 2000 + A2: 2005, Limits for Harmonic Current Emissions.**

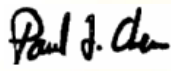
**EN 61000-3-3: 1995 + A1: 2001, Voltage Fluctuation and Flicker.**

**Immunity per EN 55020: 2002 + A1: 2003 + A2: 2005 & EN 55024:1998 + A1: 2001 + A2:2003**

- For Measurement of input Immunity
- For Measurement of immunity to RF voltage (common mode) at antenna terminal
- For Measurement of screening effectiveness
- For Measurement of immunity to induced voltages
- For Measurement of immunity from radiated fields
- IEC 61000-4-2, Edition 1.2 (2001), Electrostatic Discharge Immunity Test
- IEC 61000-4-3: 2006, Radiated, Radio-Frequency Electromagnetic Field Immunity Test.
- IEC 61000-4-4: 2004, Electrical Fast Transient/Burst Immunity Test.
- IEC 61000-4-5: 2005, Surge Immunity Test.
- IEC 61000-4-6: 2006, Immunity to Conducted Disturbances Test.
- IEC 61000-4-8, Edition 1.1 (2001), Power Frequency Magnetic Field Immunity Test.
- IEC 61000-4-11: 2004, Voltage Dips & Short Interruption Test.

**Reviewed by:**

Signed by:

  
Paul Chen / QC Manager

**Issued Date:**

2008, June 11

**Issued by:**

  
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This is the result of tests that were carried out from the submitted product sample(s) in conformity with the specification of the respective standards. The certificate holder has the right to affix the CE-Mark on the inspected product only when the product is completely complying with the required standards.



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